



IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant : Smith et al.  
Serial No. : 10/693,356  
Filed : October 24, 2003  
Title : LOW ANGLE OPTICS AND REVERSED OPTICS

Art Unit : Unknown  
Examiner : Unknown

Commissioner for Patents  
P.O. Box 1450  
Alexandria, VA 22313-1450

INFORMATION DISCLOSURE STATEMENT

Applicant submits the references listed on the attached form PTO-1449. Copies of the US patents are not being provided per the waiver posted on the PTO website.

This statement is being filed within three months of the filing date of the application or before the receipt of a first Office action on the merits. Please apply any charges or credits to Deposit Account No. 06-1050.

Respectfully submitted,

Date: November 13, 2003

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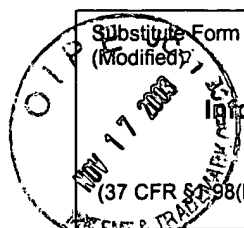
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I hereby certify under 37 CFR §1.8(a) that this correspondence is being deposited with the United States Postal Service as first class mail with sufficient postage on the date indicated below and is addressed to the Commissioner for Patents, P.O. Box 1450, Alexandria, VA 22313-1450.

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Carroll Allman  
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 Substitute Form PTO-1449 (Modified) <b>Information Disclosure Statement          by Applicant</b> (Use several sheets if necessary) (37 CFR 87.98(b)) IDS filed 11/13/2003	U.S. Department of Commerce Patent and Trademark Office	Attorney's Docket No. 06155-113001	Application No. 10/693,356
	Applicant Smith et al.		
	Filing Date October 24, 2003	Group Art Unit Not yet assigned	

**U.S. Patent Documents**

Examiner Initial	Desig. ID	Document Number	Publication Date	Patentee	Class	Subclass	Filing Date If Appropriate
	AA	5,605,641	02/25/1997	Chiba et al.			
	AB	5,734,412	03/31/1998	Hasebe et al.			
	AC	6,061,081	05/09/2000	Hasebe et al.			
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						

**Foreign Patent Documents or Published Foreign Patent Applications**

Examiner Initial	Desig. ID	Document Number	Publication Date	Country or Patent Office	Class	Subclass	Translation	
							Yes	No
	AL							
	AM							
	AN							
	AO							
	AP							

**Other Documents (include Author, Title, Date, and Place of Publication)**

Examiner Initial	Desig. ID	Document
	AQ	
	AR	
	AS	
	AT	

Examiner Signature	Date Considered
<b>EXAMINER:</b> Initials citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.	